FCC Part 1 Subpart I
FCC Part 2 Subpart J

RF EXPOSURE REPORT

FOR

SMART BRACELET

MODEL NUMBER: MICA

FCC ID: 2AB8ZND2

REPORT NUMBER: 14U19370-E4

ISSUE DATE: DECEMBER 05, 2014

Prepared for
INTEL CORPORATION.
2200 MISSION COLLEGE BOULEVARD,
SANTA CLARA, CA 95052, U.S.A

Prepared by
UL VERIFICATION SERVICES INC.
47173 BENICIA STREET
FREMONT, CA 94538, U.S.A.
TEL: (510) 771-1000
FAX: (510) 661-0888

NVLAP LAB CODE 200065-0

Revision History

Rev.	Issue Date	Revisions	Revised By
	12/5/14	Initial Issue	C. Pang

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1. ATTESTATION OF TEST RESULTS

COMPANY NAME: Intel Corporation
                        2200 Mission College Boulevard
                        Santa Clara, Ca 95052, U.S.A

EUT DESCRIPTION: Smart Bracelet

MODEL: MICA

SERIAL NUMBER: FZMK4440002J, FZMK44400022

DATE TESTED: November 17-19, 2014

APPLICABLE STANDARDS	
STANDARD	**TEST RESULTS**
FCC PART 1 SUBPART I & PART 2 SUBPART J	Pass

 UL Verification Services Inc. calculated the RF Exposure of the above equipment in accordance with the requirements set forth in the above standards, using test results reported in the test report documents referenced below and/or documentation furnished by the applicant. All indications of Pass/Fail in this report are opinions expressed by UL Verification Services Inc. based on interpretations of these calculations. The results show that the equipment is capable of demonstrating compliance with the requirements as documented in this report.
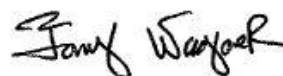
Note: The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. This document may not be altered or revised in any way unless done so by UL Verification Services Inc. and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL Verification Services Inc. will constitute fraud and shall nullify the document. This report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, any agency of the Federal Government, or any agency of any government.

Approved & Released For
UL Verification Services By: Tested By:

Chin Pang   TONY WAGONER
Senior Engineer   Lab Technician
UL Verification Services Inc.   UL Verification Services Inc.

2. TEST METHODOLOGY

All calculations were made in accordance with FCC OET Bulletin 65 Edition 97-01.

3. REFERENCES

All measurements were made as documented in test report UL Verification Services Inc. Document 14U19370-E3B for operation in the 2.4 GHz band.

Output power, Duty cycle and Antenna gain data is excerpted from the applicable test reports.

Antenna gain data is excerpted from product documentation provided by the applicant.

4. FACILITIES AND ACCREDITATION

The test sites and measurement facilities used to collect data are located at 47173 and 47266 Benicia Street, Fremont, California, USA. Line conducted emissions are measured only at the 47173 address. The following table identifies which facilities were utilized for radiated emission measurements documented in this report. Specific facilities are also identified in the test results sections.

47173 Benicia Street	47266 Benicia Street
☐ Chamber A	☐ Chamber D
☐ Chamber B	☐ Chamber E
☒ Chamber C	☒ Chamber F

UL Verification Services Inc. is accredited by NVLAP, Laboratory Code 200065-0. The full scope of accreditation can be viewed at http://www.ccsemc.com.

5. MAXIMUM PERMISSIBLE RF EXPOSURE

5.1.   FCC RULES

§1.1310 The criteria listed in Table 1 shall be used to evaluate the environmental impact of human exposure to radio-frequency (RF) radiation as specified in §1.1307(b), except in the case of portable devices which shall be evaluated according to the provisions of §2.1093 of this chapter.

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm²)	Averaging time (minutes)
(A) Limits for Occupational/Controlled Exposures				
0.3–3.0	614	1.63	*(100)	6
3.0–30	1842/f	4.89/f	*($900/f^2$)	6
30–300	61.4	0.163	1.0	6
300–1500			f/300	6
1500–100,000			5	6
(B) Limits for General Population/Uncontrolled Exposure				
0.3–1.34	614	1.63	*(100)	30
1.34–30	824/f	2.19/f	*($180/f^2$)	30

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)—Continued

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm²)	Averaging time (minutes)
30–300	27.5	0.073	0.2	30
300–1500			f/1500	30
1500–100,000			1.0	30

f = frequency in MHz
* = Plane-wave equivalent power density
  NOTE 1 TO TABLE 1: Occupational/controlled limits apply in situations in which persons are exposed as a consequence of their employment provided those persons are fully aware of the potential for exposure and can exercise control over their exposure. Limits for occupational/controlled exposure also apply in situations when an individual is transient through a location where occupational/controlled limits apply provided he or she is made aware of the potential for exposure.
  NOTE 2 TO TABLE 1: General population/uncontrolled exposures apply in situations in which the general public may be exposed, or in which persons that are exposed as a consequence of their employment may not be fully aware of the potential for exposure or can not exercise control over their exposure.

5.2.   EQUATIONS

POWER DENSITY

Power density is given by:

S = EIRP / (4 * Pi * D^2)

Where

S = Power density in mW/cm^2
EIRP = Equivalent Isotropic Radiated Power in mW
D = Separation distance in cm

Power density in units of mW/cm^2 is converted to units of W/m^2 by multiplying by 10.

DISTANCE

Distance is given by:

D = SQRT (EIRP / (4 * Pi * S))

Where

D = Separation distance in cm
EIRP = Equivalent Isotropic Radiated Power in mW
S = Power density in mW/cm^2

SOURCE-BASED DUTY CYCLE

Where applicable (for example, multi-slot cell phone applications) a duty cycle factor may be applied.

Source-based time-averaged EIRP = (DC / 100) * EIRP

Where

DC = Duty Cycle in %, as applicable
EIRP = Equivalent Isotropic Radiated Power in W

MIMO AND COLOCATED TRANSMITTERS (IDENTICAL LIMIT FOR ALL TRANSMITTERS)

For multiple chain devices, and colocated transmitters operating simultaneously in frequency bands where the limit is identical, the total power density is calculated using the total EIRP obtained by summing the EIRP (in linear units) of each transmitter.

Total EIRP = (EIRP1) + (EIRP2) + ... + (EIRPn)

where

EIRPx = Source-based time-averaged EIRP of chain x or transmitter x

The total EIRP is then used to calculate the Power Density or the Distance as applicable.

MIMO AND COLOCATED TRANSMITTERS

For multiple colocated transmitters operating simultaneously in frequency bands where different limits apply:

The Power Density at the specified separation distance is calculated for each transmitter chain or transmitter.

The fraction of the exposure limit is calculated for each chain or transmitter as
(Power Density of chain or transmitter) / (Limit applicable to that chain or transmitter).

The fractions are summed.

Compliance is established if the sum of the fractions is less than or equal to one.

5.3.   LIMITS AND IC EXEMPTION

VARIABLE LIMITS

For mobile radio equipment operating in the cellular phone band, the lowest power density limit is calculated using the lowest frequency:

824 MHz / 1500 = 0.55 mW/cm^2 (FCC)
824 MHz / 150 = 5.5 W/m^2 (IC).

FIXED LIMITS

For operation in the PCS band, the 2.4 GHz band and the 5 GHz bands:

From FCC §1.1310 Table 1 (B), the maximum value of S = 1.0 mW/cm^2

6. RF EXPOSURE RESULTS

The transmitter has the following maximum conducted <u>average</u> power:

Frequency Range (MHz)	Mode	Output Power (dBm)	Output Power (mW)	Transmitter Tolerance (dBm)	Max. Tuned Power (mW)
2402 - 2480	BLE	3.44	2.21	4	2.51

FCC Exception:

As the DUT is a portable device it was assessed in accordance using the standalone test exclusion guidelines of FCC KDB 447498 D01 General RF Exposure Guidance v05.

RF exposure evaluation was not required as determined in the following;

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Test Exclusion Threshold condition, listed below, is satisfied.

1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:
[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] ·
[√f$_{(GHz)}$] ≤ 3.0 for 1-g SAR and ≤ 7.5 for 10-g extremity SAR,[24] where
• f$_{(GHz)}$ is the RF channel transmit frequency in GHz
• Power and distance are rounded to the nearest mW and mm before calculation[25]
• The result is rounded to one decimal place for comparison
• 3.0(Head & body) and 7.5(extremities) are referred to as the numeric thresholds

The test exclusions are applicable only when the minimum *test separation distance* is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz.

The calculated Threshold is 0.9, below the threshold limit of 3; therefore the EUT is exempt from SAR.

Antenna	Tx	Frequency (MHz)	Avg Output power		Separation distance (mm)	Calculated Threshold
			dBm	mW		
2.4GHz	BLE	2440	4.00	3	5	0.9

END OF REPORT